

**N-Ch MOSFET** 

#### **General Description**

The WSF20N06 is the highest performance trench N-Ch MOSFET with extreme high cell density , which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The WSF20N06 meet the RoHS and Green Product requirement .

#### Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

**Absolute Maximum Ratings** 

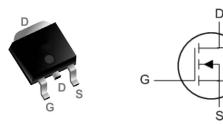
#### **Product Summery**

BVDSS	RDSON	ID
60V	35mΩ	25A

#### Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- LCD/LED back light

#### **TO-252 Pin Configuration**



Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	60	V
V <sub>GS</sub>	Gate-Source Voltage	±20	V
I <sub>D</sub> @T <sub>C</sub> =25℃	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	25	A
I <sub>D</sub> @T <sub>C</sub> =100℃	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	27	А
I <sub>D</sub> @T <sub>A</sub> =25℃	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	8	A
I <sub>D</sub> @T <sub>A</sub> =70℃	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	10	A
I <sub>DM</sub>	Pulsed Drain Current <sup>2</sup>	100	A
EAS	Single Pulse Avalanche Energy <sup>3</sup>	38	mJ
I <sub>AS</sub>	Avalanche Current	14	A
P₀@T₀=25℃	Total Power Dissipation <sup>4</sup>	35	W
P <sub>D</sub> @T <sub>A</sub> =25℃	Total Power Dissipation <sup>4</sup>	3.3	W
T <sub>STG</sub>	Storage Temperature Range	-55 to 175	°C
TJ	Operating Junction Temperature Range	-55 to 175	°C

#### **Thermal Data**

Symbol	Parameter	Тур.	Max.	Unit
R <sub>θJA</sub>	Thermal Resistance Junction-Ambient <sup>1</sup>		75	°C/W
R <sub>θJC</sub>	Thermal Resistance Junction-Case <sup>1</sup>		3	°C/W



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#### Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	60			V
$\triangle BV_{DSS} / \triangle T_J$	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25 $^\circ\!\mathrm{C}$ , I_D=1mA		0.057		V/℃
Б	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =10V , I <sub>D</sub> =16A		35	45	
R <sub>DS(ON)</sub>		V <sub>GS</sub> =5V , I <sub>D</sub> =8A		40	50	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage		1.0	1.6	2.5	V
$ riangle V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient	— V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA		-5.68		mV/°C
	Drain Source Lookage Current	$V_{DS}$ =60V , $V_{GS}$ =0V , $T_{J}$ =25 $^{\circ}$ C			1	
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =60V , V <sub>GS</sub> =0V , T <sub>J</sub> =125℃			100	uA uA
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> =±16V , V <sub>DS</sub> =0V			±10	nA
gfs	Forward Transconductance	V <sub>DS</sub> =25V , I <sub>D</sub> =18A		25		S
Rg	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		1.7	3.4	Ω
Qg	Total Gate Charge (4.5V)	V <sub>DS</sub> =30V , V <sub>GS</sub> =10V , I <sub>D</sub> =18A		20		
Q <sub>gs</sub>	Gate-Source Charge			7		nC
Q <sub>gd</sub>	Gate-Drain Charge			5		
T <sub>d(on)</sub>	Turn-On Delay Time			18		
Tr	Rise Time	V <sub>DD</sub> =30V , V <sub>GS</sub> =10V ,		15		
T <sub>d(off)</sub>	Turn-Off Delay Time	R <sub>G</sub> =6.8Ω, I <sub>D</sub> =1Α		60		– ns –
T <sub>f</sub>	Fall Time			31		
Ciss	Input Capacitance	V <sub>DS</sub> =30V , V <sub>GS</sub> =0V , f=1MHz		650		
C <sub>oss</sub>	Output Capacitance			95		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			60		

#### **Guaranteed Avalanche Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy $^5$	V <sub>DD</sub> =25V , L=0.1mH , I <sub>AS</sub> =15A	19			mJ

#### **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current <sup>1,6</sup>	$V_G = V_D = 0V$ , Force Current			25	А
I <sub>SM</sub>	Pulsed Source Current <sup>2,6</sup>				75	А
V <sub>SD</sub>	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =20A , TJ=25℃			1.3	V
t <sub>rr</sub>	Reverse Recovery Time	IF=20A ,dl/dt=100A/µs,TJ=25℃		65		nS
Qrr	Reverse Recovery Charge			85		nC

Note :

1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper,t<10sec.

2.The data tested by pulsed , pulse width  $\,\leq\,$  300us , duty cycle  $\,\leq\,$  2%

3. The EAS data shows Max. rating . The test condition is  $V_{\text{DD}}\text{=}25\text{V}, V_{\text{GS}}\text{=}10\text{V}, \text{L=}0.1\text{mH}, \text{I}_{\text{AS}}\text{=}15\text{A}$ 

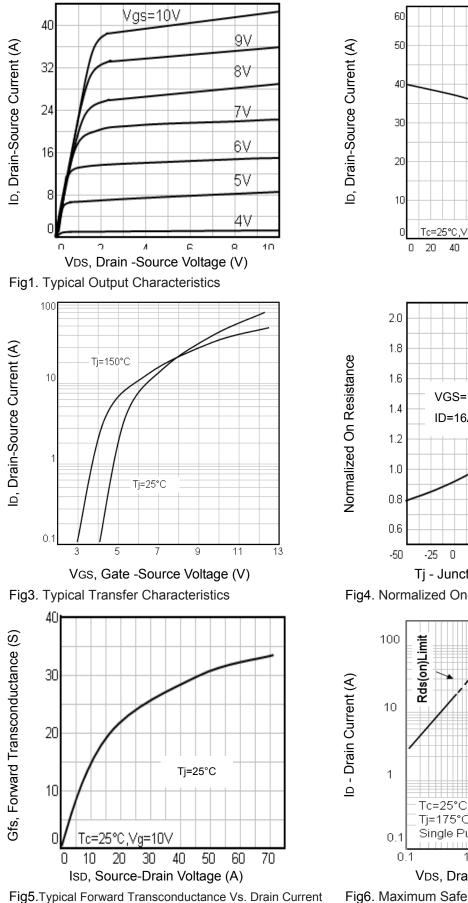
4.The power dissipation is limited by 150  $^\circ\!\mathrm{C}$   $\,$  junction temperature

5. The Min. value is 100% EAS tested guarantee.

6.The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.

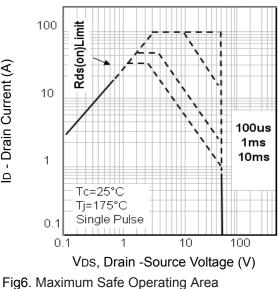


#### **Typical Characteristics**



# =10\ 60 80 100 120 140 160 180 VGS=10V ID=16A 25 50 75 100 125 150 175

Tj - Junction Temperature (°C) Fig4. Normalized On-Resistance Vs. Temperature



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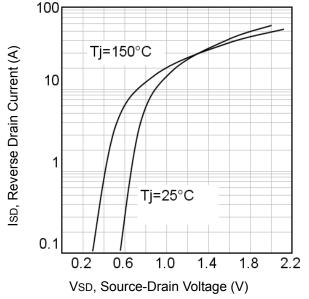


Fig7. Typical Source-Drain Diode Forward Voltage

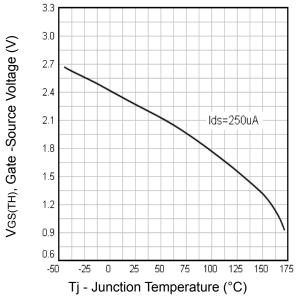


Fig9. Threshold Voltage Vs. Temperature

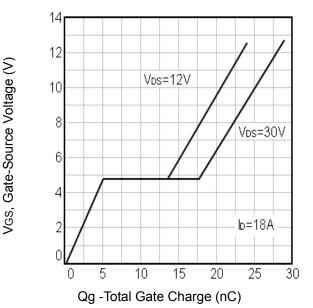
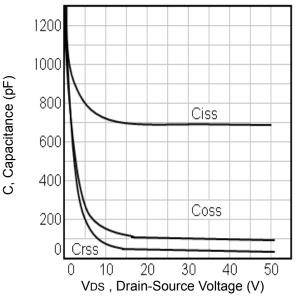
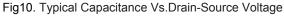


Fig8. Typical Gate Charge Vs.Gate-Source Voltage





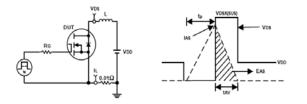


Fig11. Unclamped Inductive Test Circuit and waveforms

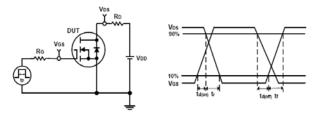


Fig12. Switching Time Test Circuit and waveforms

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